## Notice of References Cited Application/Control No. 10/698,669 Examiner Binh V. Ho Applicant(s)/Patent Under Reexamination SHEN ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2005/0060493	03-2005	Krissell et al.	711/118
*	В	US-7,051,161	05-2006	Dixit et al.	711/134
*	С	US-6,463,508	10-2002	Wolf et al.	711/133
*	D	US-2001/0020248	09-2001	Banga et al.	709/219
*	E	US-6,260,061	07-2001	Krishnan et al.	709/213
*	F·	US-2004/0098463	05-2004	Shen et al.	709/213
*	G	US-2004/0014469	01-2004	Lancieri, Luigi	455/422.1
*	Н	US-6,502,106	12-2002	Gampper et al.	707/104.1
	ı	US-			4
	J	US-			
	Κ	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N				,	
	0					
	Р					
	Q				, ,	
	R		•			·
	S			·		
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)							
	U	t.			,. · · ·				
•	٧								
	w		•						
	x								

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.